STOCHASTIC 3D RECONSTRUCTION OF CRACKED POLYCRYSTALLINE NMC PARTICLES USING 2D SEM DATA

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ABSTRACT. Li-ion battery performance is strongly influenced by their cathodes' properties and consequently by the 3D microstructure of the particles the cathodes are comprised of. During calendaring and cycling, cracks develop within cathode particles, which may affect performance in multiple ways. On the one hand, cracks reduce internal connectivity such that electron transport within cathode particles is hindered. On the other hand, cracks within particles can increase the cathode reactive surface. Due to these contradictory effects, it is necessary to quantitatively investigate how battery cycling effects cracking and how cracking in-turn influences battery performance. Thus, it is necessary to characterize the 3D particle morphology with structural descriptors and quantitatively correlate them with effective battery properties. Typically, 3D structural characterization is performed using image data. However, informative 3D imaging techniques are time-consuming, costly and rarely available, such that analyses often have to rely on 2D image data. This paper presents a novel stereological approach for generating virtual 3D cathode particles that exhibit crack networks that are statistically equivalent to those observed in 2D sections of experimentally measured particles. Consequently, more easily available 2D image data suffices for deriving a full 3D characterization of cracked cathodes particles. In future research, the virtually generated 3D particles will be used as geometry input for spatially resolved electro-chemo-mechanical simulations, to enhance our understanding of structure-property relationships of cathodes in Li-ion batteries.

5 Key words and phrases. Lithium-ion battery, cathode, active material, NMC particle, crack
6 morphology, stereological 3D reconstruction, stochastic crack network model

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1. INTRODUCTION

Li-ion batteries are vital to modern technology and transportation [1, 2]. Current research 8 initiatives in Li-ion technology aim to increase battery energy density while simultaneously 9 extending cycle-life [3, 4]. To that end, high-voltage $\text{LiNi}_x \text{Mn}_y \text{Co}_z \text{O}_2$ (NMCxyz) cathodes are 10 increasingly integrated into energy-dense cells due to their high average voltages ($\approx 3.7 \,\mathrm{V}$ vs. Li) 11 and high theoretical specific capacities $(185 - 278 \text{ mAh g}^{-1})$ [5–9]. Additionally, when cycled 12 within appropriate voltage windows (≤ 4.3 V vs. Li), these cathodes can reach upwards of a 13 thousand cycles with high capacity retention [3]. Currently, NMC chemistries are the primary 14 candidates for cathode materials that lead to energy-dense Li-ion batteries, spanning both liq-15 uid [10–14] and solid-state [15–19] electrolyte systems. However, NMC cathodes can exhibit 16 capacity-fade mechanisms including transition-metal dissolution [20, 21], surface reconstruc-17 tion [8, 10], electrolyte reactivity and gassing [8, 22, 23], and particle cracking [24, 25]. These 18 fade mechanisms are highly coupled [9, 12, 15, 26–30]. For example, in liquid systems, particle 19 cracking can expose uncoated active material to liquid electrolyte, resulting in increased elec-20 trochemical side reactions and surface reconstruction [8, 27]. In solid systems, cathode cracking 21

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can result in reduced surface area to either the solid-state electrolyte or the electron-conducting
phase, resulting in increased charge transfer and ohmic resistance, respectively [17–19].

Because a significant amount of cathode capacity-fade mechanisms are related to secondary-24 particle cracking, researchers typically evaluate cathode "aging" through qualitative crack anal-25 ysis [12, 28]. Cathode particle cracking can occur for different reasons. First, during manu-26 facturing, cathode cracking can occur during the calendaring process [7, 31, 32]. The cracks 27 formed during calendaring typically originate at particle/particle or particle/current-collector 28 contacts and tend to form long cracks that cleave particles. Second, cathode cracking can oc-29 cur during formation cycles due to non-ideal primary particle grain orientations. These initial 30 "break-in" cracks tend to be small and are significantly influenced by the grain shapes, sizes, and 31 orientations [33, 34]. Break-in cracking is currently the primary focus for physics-based chemo-32 mechanical models [33, 35–38]. Finally, cracks can form during operation when the cathodes are 33 cycled at higher voltage ranges, either due to increased voltage bounds or due to voltage slip-34 page [12, 39]. At high voltages or during high delithiation demands, the lithium concentration 35 on the cathode surface can drop below a minimum concentration threshold causing irreversible 36 reconstruction of the host crystal. This reconstruction reduces the specific capacity and induces 37 significant local stain, leading to secondary-particle cracking [29, 33]. 38

Currently, structural post-mortem analysis of cathode particle fracture is primarily conducted 39 using 2D scanning electron microscope (SEM) images and X-ray techniques [11, 12, 29, 40–42]. 40 Since a quantitative analysis of such 2D images can be difficult, the comparison of differently 41 aged post-mortem cathodes is often performed by means of visual inspection [11, 12, 30]. Such a 42 qualitative analysis is typically accompanied by quantitative electrochemical analysis (e.g., elec-43 trochemical impedance spectroscopy, incremental capacity analysis [12, 29]) and post-mortem, 44 atomistic-scale surface-sensitive techniques [11, 20, 29, 42, 43]. However, relying on qualita-45 tive cracking-extent assessments introduces subjectivity in the analysis, highlighting the need 46 for more quantitative and reproducible methods to characterize cathode-particle fracture. A 47 quantitative analysis of cracks in 2D SEM data has been conducted, e.g., in [40, 41]. However, 48 2D images of cracked particles depict only planar sections of the actual 3D microstructure. In 49 other words, a 2D slice of a cathode electrode represents just a small portion of the 3D system, 50 which includes out-of-plane features such as tortuous crack connections. 51

In contrast to 2D crack analysis, it is significantly more difficult to segment and identify crack 52 structures in 3D images [44, 45] and to reassemble fragments of fractured particles [46]. This 53 increased difficulty is due to the fact that 3D imaging (e.g., via nano-CT) is often accompanied 54 with a lower resolution than 2D microscopy techniques (e.g., SEM), which produce image data 55 on a similar length scale—i.e., fine structures caused by cracks often exhibit a bad contrast in 3D 56 image data. Moreover, a quantitative crack analysis requires computation of metrics to describe 57 cracks in 3D [47]. Unfortunately, the necessary 3D imaging equipment is expensive and often 58 less available than comparable 2D imaging equipments and their analysis tools [20, 48, 49]. A 59 potential remedy is provided by stochastic 3D modeling, which can generate countless virtual 60 NMC particles exhibiting statistically similar properties as the relatively low number of particles 61 that have been imaged in 3D [50]. In general, realizations of stochastic 3D models for material 62 microstructures, such as those proposed in [51, 52], can serve as geometry inputs for mechanical 63 and electrochemical simulations. These simulations can help to investigate properties like crack 64 propagation in materials and their elastostatic or -plastic responses [33, 53–55]. By performing 65 such simulation studies on generated morphologies quantitative structure-property relationships 66 can be derived [56, 57]. 67

As mentioned above, measured 3D image data is not always accessible. Therefore approaches 68 have been developed to calibrate stochastic 3D models utilizing only 2D image data [58]. Re-69 cently, a stochastic nanostructure model based on generative adversarial networks (GAN) was 70 introduced, which mimics the 3D polycrystalline grain architecture of non-cracked NMC parti-71 cles [59] by only using 2D electron backscatter diffraction (EBSD) cross sections for calibration. 72 In the present paper, a stochastic 3D model is proposed that can generate realistic cracks in 73 virtual polycrystalline NMC particles, which propagate along grain boundaries. Similar to the 74 approach considered in [60], our model is based on random tessellations, where certain facets are 75 dilated to mimic cracks. In this work, a facet between two grains is either intact or fully cracked 76 without intermediate case (that is all surface elements of the facet are either intact or cracked. 77 The model is calibrated and validated by comparing planar cross sections of the stochastic 3D 78 crack network model with 2D SEM image data, utilizing several geometric descriptors charac-79 terizing the morphology of the crack phases. Additionally, to emphasize the strength of our 80 stereological modeling approach, geometric descriptors related to effective battery properties 81 are determined, which cannot be reliably derived from 2D images. 82

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2. MATERIALS AND IMAGE PROCESSING

The focus of this section is to describe the materials considered in the present paper, as 84 well as on the processing of 2D SEM image data of these materials. First, in Section 2.1, 85 the cathode materials and their cycling history are discussed. Then, in Section 2.2, several 86 image processing techniques are described, where gray-scale images of planar cross sections 87 of the cathodes, obtained by SEM imaging, are phasewise segmented using a 2D U-net and, 88 afterwards, particlewise segmented utilizing a marker-based watershed transform. Additionally, 89 morphological operations are used to denoise the crack phase. Finally, in Section 2.3, the set of 90 segmented 2D images is decomposed into two subsets, based on the predominance of short or 91 long cracks. Later on, in Section 4 the introduced crack model is calibrated to both subsets, to 92 reproduce the wide structural variability of cracked NMC particles. 93

2.1. Electrode materials and cycling history. The active electrode material used in the
present paper consisted of LiNi_{0.5}Mn_{0.3}Co_{0.2}O₂ (NMC532) and was taken from the same batch
of cells cycled in our previous work [41], where the particles had similar polycrystalline architectures as those shown in [61]. The electrodes consisted of 90 wt% NMC532, 5wt% Timcal
C45 carbon and 5wt% Solvay 5130 PVDF binder. The coating thickness was 62 µm with 26.1%
porosity.

The cell was formed by charging to $1.5 \,\mathrm{V}$, holding at open-circuit for 12 hours, and then 100 cycling 3 times between 3 V and 4.1 V using a protocol consisting of C/2 constant-current and 101 constant-voltage at $4.1 \,\mathrm{V}$ until the current dropped below $\mathrm{C}/10$. The cells were then degassed, 102 resealed, and prepared for fast charging at 20 °C. Subsequently, the cells were cycled using a 103 protocol of fast charging at 6C constant current between 3V and 4.1V followed by constant-104 voltage hold until 10 minutes total charge time had elapsed. Charge was followed by 15 minutes 105 of open circuit and discharge at C/2 to 3V, followed by a final rest for 15 minutes. The materials 106 used in this paper were cycled 200 times under these conditions. 107

2.2. Preprocessing and analysis of 2D SEM image data. The NMC electrode material
was removed from the cells and a small sample cut from the electrode sheet. The sample was

then cross sectioned using an Ar-ion beam cross-sectional polisher (JOEL CP19520). The crosssectioned face was then imaged in an SEM system with a pixel size of 38.5 nm. A representative
cross section, derived by SEM imaging, is presented in Figure 1 (top).

For image processing, we first describe the image processing steps which were performed 113 in [41] to segment the 2D SEM image data of the cross sections with respect to phases and 114 particles, i.e., each pixel is classified either as solid phase, crack phase or background, where 115 each particle is assigned with a unique label. Note that the raw image data depicted scale bars 116 for indicating the corresponding length scales (which have been produced by the microscope's 117 software). Since the scale bars can adversely impact subsequent image processing steps, the 118 *inpainting_biharmonic* method of the scikit-image package in Python [62] has been utilized to 119 remove scale bars. Then, a generative adversarial network [63] has been deployed to increase the 120 resolution (super-resolution) such that pixel sizes of 14.29 nm have been achieved, facilitating 121 the assignment of pixels to phases (i.e., solid phase, crack phase, background). 122

To obtain a phasewise segmentation, a 2D U-net was deployed to classify the phase affiliation for each pixel in 2D SEM cross sections. More precisely, the network's output is given by pixelwise probabilities of phase membership. By deploying thresholding techniques onto these pixelwise probabilities, a phase-wise segmentation has been obtained, see [41] for further details. In particular, Figure 1 indicates that the data has been segmented reasonably well, i.e., only a low, statistically negligible number of particles (see bottom left) exhibits larger misclassified areas.

The particle-wise segmentation was obtained by means of a marker-based watershed trans-130 form on the Euclidean distance transform, denoted by D in the following. More precisely, 131 $D: W \to \mathbb{R}_+ = [0, \infty)$ is a mapping, which assigns each pixel $x \in W$ its distance to the back-132 ground phase. Here, $W \subset \mathbb{Z}_{\rho}^2$ represents the sampling window, where $\mathbb{Z}_{\rho} = \{\ldots, -\rho, 0, \rho, \ldots\}$ 133 and $\rho > 0$ denotes the pixel length. Note that the watershed function of the Python package 134 scikit-image [62] was deployed on -D, where the markers (i.e., the positions of particles to 135 be segmented) are obtained by thresholding D at some distance level r > 0, where r is set 136 equal to 50 pixels. After the application of the watershed algorithm, truncated particles were 137 removed in order to avoid edge effects. In addition, we removed regions within the segmented 138 image that may have resulted from oversegmentation or falsely segmented phases, which can 139 occur due to shine-through effects during SEM imaging. To identify such regions, we first used 140 the Gaussian Mixture method from the scikit-learn package in Python [64]. This method was 141 employed to fit a mixed bivariate Gaussian distribution (with two components) to the pairs of 142 area-equivalent diameters and eccentricity values of the segmented regions in the image [62]. 143 Note that the eccentricity of a segmented region is defined as the eccentricity of a fitted ellipse 144 that has the same first and second moments. After fitting the mixed Gaussian distribution, 145 its first component, i.e., a bivariate Gaussian distribution, exhibited a mean value vector com-146 prising a relatively large area-equivalent diameter and low eccentricity (which corresponds to 147 circular regions). We assumed that this component corresponds to correctly segmented par-148 ticles in the image. In contrast, the second component, characterized by a mean vector with 149 150 smaller area-equivalent diameters and higher eccentricity, was assumed to represent incorrect segmentations. Consequently, we removed regions from the segmentations for which the vector 151 of area-equivalent diameter and eccentricity was more likely to belong to the second component, 152 as determined by the fitted Gaussian mixture model. 153

Note that a few particles affected by shine-trough effects from SEM imaging remain. However, their small proportion has a negligible impact on the overall statistical properties of the particle set. This procedure is performed on 13 SEM cross sections, each consisting of 5973×3079 pixels, which corresponds to approximately $85 \,\mu\text{m} \times 44 \,\mu\text{m}$ with a resolution of $\rho = 14.29 \,\text{nm}$. Note that these 13 cross sections are derived from the same cathode and are partly overlapping. In each cross section, between 43 and 60 particles were detected. An exemplary phasewise segmented

160 cross section is shown in Figure 1 (bottom).



FIGURE 1. 2D SEM image (top) and its phasewise segmentation (bottom), where each pixel is classified as background (white), solid (gray) or crack (black). Note that truncated and small particles with a large eccentricity have been removed.

In addition to the preprocessing procedure explained above and proposed in [41], the following 161 data processing steps have been carried out. First, since some SEM images depict overlapping 162 areas, duplicates were removed. More precisely, all pairs of particles from overlapping images 163 were registered, i.e., for each pair of particles a rigid transformation is determined which max-164 imizes the correspondence of the first particle after application of the transformation with the 165 second particle, where the agreement is measured by means of the cross correlation in scikit-166 image [62]. If pairs of registered particles exhibit a large correspondence, a duplicate is detected, 167 which is omitted in further analysis. Furthermore, to reduce the number of very small cracks, 168 e.g., caused by noise or by several connected components of the crack phase that actually belong 169 to the same crack, morphological opening, followed by morphological closing, was performed 170 on the crack phase. For both morphological operations, a disk-shaped structuring element with 171 radius $r_o = 1$ for opening and $r_c = 3$ for closing was used. 172

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In summary, the image processing procedure described above resulted into 506 images depicting the phasewise segmentation of NMC particles in planar sections, i.e., each pixel is classified either as solid (active NMC material), crack, or background. Each of these images depicts a single cross section of a NMC particle, which shows a certain network of cracks. In the following sections, an individual particle is denoted by $P_{\rm ex}$.

2.3. Decomposition of the set of segmented particles into two subsets. In this section
we explain how the set of segmented particles, described in Section 2.2, is decomposed into two
subsets with predominantly long and short cracks, respectively. This subdivision is motivated by
the structural heterogeneity observed in the crack networks of segmented particle cross sections.
In Section 4, the stochastic crack model that is introduced in Section 3, is fitted separately to
both subsets.

For this classification, for each particle P_{ex} , we consider a continuous representation in the two-dimensional Euclidean space \mathbb{R}^2 , denoting its solid phase by $\Xi_{\text{solid}}^{(\text{ex})} \subset \mathbb{R}^2$ and its crack phase by $\Xi_{\text{crack}}^{(\text{ex})} \subset \mathbb{R}^2$, where each pixel of P_{ex} is considered as patch (i.e., as a square subset of \mathbb{R}^2). Thus, in the following we will write

$$P_{\rm ex} = \left(\Xi_{\rm solid}^{\rm (ex)}, \Xi_{\rm crack}^{\rm (ex)}\right) \tag{1}$$

for the continuous representation of a particle. Furthermore, by \mathcal{G} we denote the set of continuous representations of all 506 particles. The dataset \mathcal{G} is comprised of particles with sizes ranging from 1.39 µm to 13.62 µm (in terms of their area-equivalent diameters, denoted by $\operatorname{aed}(P_{ex})$).

By visual inspection of segmented particles, it becomes appearant that the crack networks of some particles consist predominantly of short and others of long cracks, see Figures 1 and 2. Motivated by these morphological differences, the set \mathcal{G} is subdivided into two disjoint subsets, \mathcal{G}_{short} and \mathcal{G}_{long} . To decide for a given particle P_{ex} if it belongs to \mathcal{G}_{short} or \mathcal{G}_{long} , a skeletonization algorithm [65] was applied to the crack phase of P_{ex} , where each connected component of the crack phase Ξ_{crack} is represented by its center line, which we refer to as a skeleton segment. The family of all skeleton segments of a particle P_{ex} is called skeleton and denoted by $\mathcal{S}(P_{ex})$.

If the longest crack skeleton segment of a particle P_{ex} is shorter than or equal to $t \cdot \text{aed}(P_{\text{ex}})$ for some threshold t > 0, then P_{ex} is assigned to $\mathcal{G}_{\text{short}}$, otherwise P_{ex} is assigned to $\mathcal{G}_{\text{long}}$. Note that the area-equivalent diameter aed(P) of particle P_{ex} is given by

$$\operatorname{aed}(P_{\operatorname{ex}}) = \sqrt{\frac{4 \,\nu_2(\Xi_{\operatorname{solid}} \cup \Xi_{\operatorname{crack}})}{\pi}},$$

where $\nu_2(A)$ denotes the 2-dimensional Lebesgue measure, i.e., the area of a set $A \subset \mathbb{R}^2$. Thus, formally, the sets $\mathcal{G}_{\text{short}}$ and $\mathcal{G}_{\text{long}}$ can be written as

$$\mathcal{G}_{\text{short}} = \{ P_{\text{ex}} \in \mathcal{G} \colon \max_{S \in \mathcal{S}(P_{\text{ex}})} \mathcal{H}_1(S) \le t \cdot \text{aed}(P_{\text{ex}}) \} \text{ and } \mathcal{G}_{\text{long}} = \mathcal{G} \setminus \mathcal{G}_{\text{short}}$$

where $\mathcal{H}_1(S)$ denotes the 1-dimensional Hausdorff measure of a skeleton segment $S \in \mathcal{S}(P_{\text{ex}})$, which corresponds to the length of S^{-1} . It turned out that t = 0.55 is a reasonable choice, which splits \mathcal{G} into two subsets $\mathcal{G}_{\text{short}}$ and $\mathcal{G}_{\text{long}}$, each containing particles from the entire range of observed particle sizes, where $\mathcal{G}_{\text{short}}$ comprises 423 particles and $\mathcal{G}_{\text{long}}$ consists of 83 particles. For larger values of t the statistical representativeness of $\mathcal{G}_{\text{long}}$ diminishes, whereas for smaller values of t we observed that the resulting set $\mathcal{G}_{\text{long}}$ was comprised of particles with relatively small cracks—which would have made the decomposition of particles into $\mathcal{G}_{\text{short}}$ and $\mathcal{G}_{\text{long}}$ redundant.

¹The length of a skeleton segment was approximated by the number of pixels multiplied with the resolution of $\rho = 14.29$ nm.

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FIGURE 2. Segmented NMC particles together with their skeletons (yellow), where the skeleton segment of the longest crack is highlighted in red. The particle on the left-hand side belongs to \mathcal{G}_{short} , consisting of predominantly short cracks, while the particle on the right-hand side belongs to \mathcal{G}_{long} , exhibiting long cracks.

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3. Stochastic 3D model for cracked NMC particles

In this paper, a stochastic 3D model is proposed, which generates cracks in (simulated) pris-211 tine MNC particles hierarchically on different length scales. Two different kinds of data are used 212 as model inputs. First, to generate pristine NMC particles in 3D, exhibiting a polycrystalline 213 inner structure, we draw samples from the stochastic particle model introduced in [50]. Then, 214 we use 2D SEM image data to stereologically calibrate a stochastic 3D model for adding cracks, 215 where we assume that cracks propagate along the polycrystalline grain boundaries through the 216 particles without having a preferred direction. It is important to emphasize that the proposed 217 stochastic crack model generates virtual, but realistic cracked NMC particles in 3D, even though 218 it is calibrated using only 2D image data. 219

In Section 3.1, the main features of the stochastic 3D model proposed in [50] are summa-220 rized, which is used to generate the virtual, pristine NMC particles. To efficiently represent 221 the neighborhood relationships of individual grains of a particle, in Section 3.2 a graph-based 222 data structure is introduced by means of Laguerre tessellations. Subsequently, in Section 3.3, a 223 stochastic model is presented, which incorporates single cracks into the (previously simulated) 224 pristine NMC particles, utilizing the graph-based representation via tessellations stated in Sec-225 tion 3.2. Then, in Section 3.4, it is shown how the single-crack model can be applied multiple 226 times to generate a random crack network consisting of several cracks within a given parti-227 cle. Finally, in Section 3.5, an extended stochastic crack network model is presented, which is 228 deployed for modeling the entire crack phase of NMC particles in 3D. 229

3.1. Stochastic 3D model for pristine polycristalline NMC particles. In [50] a spatial 230 stochastic model for the 3D morphology of pristine polycristalline NMC particles has been 231 developed and calibrated by means of tomographic image data. More precisely, nano-CT data 232 depicting the outer shell of NMC particles has been leveraged to calibrate a random field model 233 on the three-dimensional sphere, whose realizations are virtual outer shells of NMC particles 234 that are statistically similar to those observed in the nano-CT data. Furthermore, a random 235 Laguerre tessellation model for the inner grain architecture of NMC particles (which lives on a 236 smaller length scale) has been calibrated using 3D EBSD data. 237

Note that a Laguerre tessellation in \mathbb{R}^3 is a subdivision of the three-dimensional Euclidean 238 space (or some sampling window within \mathbb{R}^3) that is given by some marked point pattern 239 $\{(s_n, r_n), n \in \mathbb{N}\}$, where $s_n \in \mathbb{R}^3$ is called a seed or generator point, and $r_n \in \mathbb{R}$ is an (ad-240 ditive) weight, for each $n \in \mathbb{N} = \{1, 2, \ldots\}$, see [66, 67]. The interior of the grain generated by 241 the *n*-th marked seed point (s_n, r_n) of a Laguerre tessellation is defined as set of points $x \in \mathbb{R}^3$, 242 which are closer to s_n than to all other seed points $s_k, k \neq n$, with respect to the "distance 243 function" $d: \mathbb{R}^3 \times \mathbb{R}^4 \to \mathbb{R}$ given by d(x, (s, r)) = |x - s| - r for all $x, s \in \mathbb{R}^3$ and $r \in \mathbb{R}$, where 244 $|\cdot|$ denotes the Euclidean norm in $\mathbb{R}^{3,2}$ Thus, formally, the grain $g_n \subset \mathbb{R}^3$ generated by the 245 *n*-th marked seed point (s_n, r_n) is given by 246

$$g_n = \left\{ x \in \mathbb{R}^3 : d(x, (s_n, r_n)) \le d(x, (s_k, r_k)) \quad \text{for all } k \neq n \right\}.$$

$$\tag{2}$$

To compute grains g_n for a given set of marked seed points we use the GeoStoch library [68]. Both stochastic models mentioned above, i.e., the random field model for the outer shell and the random tessellation model for the inner grain architecture, have been combined in [50], to derive a multi-scale 3D model for pristine NMC particles with full inner grain architecture. Thus, in the first modeling step of the present paper, we will draw realizations from the multi-

scale 3D model of [50] for the generation of virtual pristine NMC particles, to which cracks will be added in the subsequent modeling steps. Using an analogous notation like that considered in Eq. (1), the simulated pristine NMC particles will be denoted by $P_{\rm pr} = (\Xi_{\rm solid}^{\rm (pr)}, \emptyset)$, where

$$\Xi_{\text{solid}}^{(\text{pr})} = \bigcup_{n \in I} g_n \subset \mathbb{R}^3$$

for some index set $I \subset \mathbb{N}$. The stochastic crack model introduced later on (in Sections 3.3 to 3.5) assigns facets, i.e. planar grain boundary segments, of the pristine particle $P_{\rm pr}$ with crack widths to introduce a crack network. To do so, we first derive an alternative graph representation of the Laguerre tessellation $\{g_n, n \in I\}$ which describes the grain architecture of $P_{\rm pr}$.

3.2. Graph representation of pristine grain architectures. In the literature, a Laguerre tessellation in \mathbb{R}^3 is usually given by a collection of grains $g_n \subset \mathbb{R}^3$ as defined in Eq. (2). However, alternatively, such a tessellation can be represented as a collection of planar facets given by

$$g_n \cap g_k = \{x \in \mathbb{R}^3 : d(x, (s_n, r_n)) = d(x, (s_k, r_k))\}$$

for $n, k \in \mathbb{N}$ with $n \neq k$ and $\mathcal{H}_2(g_n \cap g_k) > 0$, where $\mathcal{H}_2(g_n \cap g_k)$ is the 2-dimensional Hausdorff measure of $g_n \cap g_k \subset \mathbb{R}^3$, which corresponds to the area of $g_n \cap g_k$. Thus, the sets $g_n \cap g_k$ are convex plane segments being the intersection of neighboring grains, the union of which is equal to the union of the boundaries ∂g_n of the convex polyhedra g_n considered in Eq. (2).

Furthermore, to describe the neighborhood structure of the facets, we consider the so-called neighboring facet graph, denoted by G = (F, E). The set F of its vertices is the collection of planar facets of the Laguerre tessellation, and E is its set of edges, where two facets $f, f' \in F$ are connected by an edge $e \in E$ if they are adjacent, which means that $f \cap f'$ is a line segment with positive length, i.e., $\mathcal{H}_1(f \cap f') > 0$, see Figures 3a and 3b.

3.3. Single crack model. In this section, we describe the stochastic model which will be used for the insertion of single cracks into virtual NMC particles, whose polycristalline grain architecture is given by a Laguerre tessellation within a certain (bounded) sampling window

 $^{^{2}}$ In the mathematical literature, the grains of a Laguerre tessellation are often called "cells". However, for modeling the polycrystalline materials considered in the present paper, the wording "grain" is used.

 $W \subset \mathbb{R}^3$, as stated in Section 3.1, and represented by the neighboring facet graph G = (F, E)introduced in Section 3.2.

Assuming that cracks propagate along grain boundaries [27], we will model cracks as collections of dilated adjacent facets. With regard to the graph-based representation of tessellations stated in Section 3.2, this means that a subset $C \subset F$ will be chosen such that for each pair $f, f' \in C$ with $f \neq f'$, there exists a sequence of adjacent facets $f_1, \ldots, f_n \in C$ such that

- 281 $f_1 = f$ and $f_n = f'$. This allows generating, if desired, particles with a relatively low quantity
- of cracked facets, but with relatively long contiguous cracks, which would be not possible with
- 283 a stochastic approach not considering sequences of adjacent facets.



FIGURE 3. 2D scheme of the workflow to generate an individual crack along grain boundaries. For a (Laguerre) tessellation within a bounded sampling window (a), the neighboring facet graph is determined, i.e., facets are considered to be vertices of the graph (black rectangles), which are connected by edges (blue) if the underlying facets are adjacent (b). An initial facet (red) is chosen at random and assigned to the set C of crack facets (c). Iteratively, the *n*-th neighboring facet which is aligned "best" with the set C is assigned to it (d).

More precisely, to generate a set of dilated crack facets as described above, an algorithm is proposed consisting of the following steps:

- (i) Initialize the set of crack facets, putting $C = \emptyset$.
- (ii) Generate the number $n_{\text{facets}} \in \mathbb{N}$ of crack facets, drawing a realization $\hat{n}_{\text{facets}} > 0$ from
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a Weibull distributed random variable N_{facets} with some scale parameter $\lambda_{\text{W}} > 0$ and shape parameter $k_{\text{W}} > 0$, and putting $n_{\text{facets}} = \text{round}(\hat{n}_{\text{facets}})$, where

$$\operatorname{round}(\hat{n}_{\text{facets}}) = \begin{cases} \lfloor \hat{n}_{\text{facets}} \rfloor & \text{if} \quad \hat{n}_{\text{facets}} - \lfloor \hat{n}_{\text{facets}} \rfloor < 0.5, \\ \lfloor \hat{n}_{\text{facets}} \rfloor + 1 & \text{else}, \end{cases}$$
(3)

- which means rounding to the closest integer, with $\lfloor \hat{n}_{\text{facets}} \rfloor$ denoting the largest integer being smaller than \hat{n}_{facets} .
- (iii) Choose an initial facet $f \in F$ at random and assign it to the set of crack facets C. Furthermore, let $g: F \to \mathbb{R}^3$ denote a function, which maps a facet $f \in F$ onto its normal vector $v = (v_1, v_2, v_3)$ with length 1 and $v_1 \ge 0$.

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- (iv) Compute the average normal vector $v_C = \sum_{f \in C} g(f) |\sum_{f \in C} g(f)|^{-1}$, to control the alignment of the next facet, to be assigned to C.
- (v) Determine the set $A = \{f \in F \setminus C : f \cap f' \in E \text{ for some } f' \in C\} \subset F \setminus C$, containing the facets that are adjacent to C, but not contained in C.
- 299 (vi) Add the facet $f \in A$ given by

$$f = \underset{f \in A}{\operatorname{argmax}} |\langle g(f), v_C \rangle| \tag{4}$$

- to C, for which the normal g(f) has the best directional alignment with the average normal vector v_c computed in step (iv), where $\langle \cdot, \cdot \rangle$ denotes the dot product.
- (vii) Repeat steps (iv) to (vi) until $\#C = n_{\text{facets}}$, where # denotes cardinality.
- (viii) Draw a realization $\delta > 0$ from a gamma distributed random variable Δ with some shape parameter $k_{\Gamma} > 0$ and scale parameter $\theta_{\Gamma} > 0$.
- (ix) Dilate each crack facet $f \in C$ using the structuring element $B_{\delta} = \{x \in \mathbb{R}^3 : |x| \leq \delta/2\}$, and determine the set $\bigcup_{f \in C} (f \oplus B_{\delta})$, where \oplus denotes Minkowski addition. Note that the set $\bigcup_{f \in C} (f \oplus B_{\delta})$ represents a crack where each facet $f \in C$ is dilated with the same thickness δ .

309 This algorithm is visualized in Figure 3.

In summary, the stochastic model for single cracks described above is characterized by the 4-dimensional parameter vector $\theta_1 = (\lambda_W, k_W, k_\Gamma, \theta_\Gamma) \in \mathbb{R}^4_+$, where λ_W and k_W control the length of cracks, whereas k_Γ and θ_Γ affect their thickness.

Recall that in Section 3.1 we introduced the notation $P_{\rm pr} = (\Xi_{\rm solid}^{\rm (pr)}, \emptyset)$ for simulated pristine NMC particles. Analogously, for a given pristine particle $P_{\rm pr} = (\Xi_{\rm solid}^{\rm (pr)}, \emptyset)$, a particle with a single crack will be denoted by $P_{\theta_1} = (\Xi_{\rm solid}^{(\theta_1)}, \Xi_{\rm crack}^{(\theta_1)})$, where $\Xi_{\rm solid}^{(\theta_1)} \cup \Xi_{\rm crack}^{(\theta_1)} = \Xi_{\rm solid}^{\rm (pr)}$, with $\Xi_{\rm solid}^{(\theta_1)}, \Xi_{\rm crack}^{(\theta_1)} \subset \mathbb{R}^3$ being the solid and crack phase of P_{θ_1} , respectively. More precisely, it holds that

$$\Xi_{\text{crack}}^{(\theta_1)} = \left\{ x \in \Xi_{\text{solid}}^{(\text{pr})} \colon \operatorname{dist}(x, f) \le \frac{\delta}{2} \text{ for some } f \in C \right\}$$

and $\Xi_{\text{solid}}^{(\theta_1)} = \Xi_{\text{solid}}^{(\text{pr})} \setminus \Xi_{\text{crack}}^{(\theta_1)}$, where $\text{dist}(x, f) = \min\{|x - y| : y \in f\}$ denotes the Euclidean distance from $x \in \mathbb{R}^3$ to the set $f \in C$.

Note that the spatial orientation of the random crack depends solely on the initial facet f, which is chosen at random (uniformly) from the set of facets F. Since the orientation of a facet of a Laguerre tessellation is uniformly distributed on the space of possible facet orientations, the single crack model is isotropic. A potential anisotropy of the crack network could be modeled by modifying the selection criterion formulated in Eq. (4).

325 3.4. Crack network model. Typically, the crack phase of particles observed in experimental 326 2D SEM data consists of more than one crack and forms complex crack networks, see Figure 1. 327 Thus, to model the crack phase of particles consisting of multiple cracks, we draw a realization 328 $n_{\text{cracks}} \in \mathbb{N} \cup \{0\}$ from a Poisson distributed random variable N_{cracks} with some parameter 329 $\lambda_{\text{P}} > 0$. Furthermore, let $P_{\theta_1,1}, \ldots, P_{\theta_1,n_{\text{cracks}}}$ with $P_{\theta_1,i} = (\Xi_{\text{solid}}^{(\theta_1,i)}, \Xi_{\text{crack}}^{(\theta_1,i)})$ for $i = 1, \ldots, n_{\text{cracks}}$ 330 denote independent realizations of the single crack model introduced in Section 3.3, applied to 331 one and the same pristine particle $P_{\text{pr}} = (\Xi_{\text{solid}}^{(\text{pr})}, \emptyset)$. Overlaying these realizations results in a 332 realization of the crack network model $P_{\theta_2} = (\Xi_{\text{solid}}^{(\theta_2)}, \Xi_{\text{crack}}^{(\theta_2)})$ with parameter vector

$$\theta_2 = (\theta_1, \lambda_{\rm P}) = (\lambda_{\rm W}, k_{\rm W}, k_{\Gamma}, \theta_{\Gamma}, \lambda_{\rm P}) \in \mathbb{R}^5_+, \tag{5}$$

10

where $\Xi_{\text{crack}}^{(\theta_2)} = \bigcup_{i=1}^{n_{\text{crack}}} \Xi_{\text{crack}}^{(\theta_1,i)}$ and $\Xi_{\text{solid}}^{(\theta_2)} = \Xi_{\text{solid}}^{(pr)} \setminus \Xi_{\text{crack}}^{(\theta_2)}$. By visual inspection of the SEM data, see Figure 1, it is obvious that the distributions of

By visual inspection of the SEM data, see Figure 1, it is obvious that the distributions of the random number N_{cracks} and size N_{facets} of individual cracks should depend on the size of the underlying pristine particle P_{pr} , i.e., small particles tend to have less and shorter cracks, whereas large particles exhibit more and longer cracks. Therefore, we assume that the scale parameters $\lambda_{\text{P}}, \lambda_{\text{W}} > 0$ considered in Eq. (5) are given by

$$\lambda_{\rm P} = \lambda_{\rm P}(c_{\rm P}, c_{\rm dim}) = c_{\rm P}\nu_3 \left(\Xi_{\rm solid}^{\rm (pr)}\right)^{c_{\rm dim}}, \qquad \lambda_{\rm W} = \lambda_{\rm W}(c_{\rm W}, c_{\rm dim}) = c_{\rm W}\nu_3 \left(\Xi_{\rm solid}^{\rm (pr)}\right)^{1-c_{\rm dim}} \tag{6}$$

for some constants $c_{\rm P}, c_{\rm W} > 0$ and $c_{\rm dim} \in [0, 1]$, where ν_3 denotes the 3-dimensional Lebesgue measure, i.e., $\nu_3(\Xi_{\rm solid}^{\rm (pr)})$ is the volume of $P_{\rm pr}$. This implies that the porosity

$$p = \frac{\mathbb{E}\nu_3(\Xi_{\text{crack}}^{(\theta_2)})}{\nu_3(\Xi_{\text{solid}}^{(\text{pr})})},$$

of the crack network model P_{θ_2} does not (or only slightly) depend on the volume $\nu_3(\Xi_{\text{solid}}^{(\text{pr})})$ of the underlying pristine particle P_{pr} , which can be shown as follows. Since the random variables $N_{\text{cracks}}, N_{\text{facets}}, \Delta$ are assumed to be independent, it holds that³

$$p = \frac{\mathbb{E}\nu_3(\Xi_{\text{crack}}^{(\theta_2)})}{\nu_3(\Xi_{\text{solid}}^{(\text{pr})})} \approx \frac{\alpha \mathbb{E}N_{\text{cracks}} \mathbb{E}N_{\text{facets}} \mathbb{E}\Delta}{\nu_3(\Xi_{\text{solid}}^{(\text{pr})})} = \frac{\alpha \lambda_{\text{P}} \lambda_{\text{W}} \gamma_{k_{\text{W}}} \mathbb{E}\Delta}{\nu_3(\Xi_{\text{solid}}^{(\text{pr})})},$$
(7)

where $\alpha > 0$ is the mean area of planar facets of the Laguerre tessellation describing the grain architecture of $P_{\rm pr}$ and $\gamma_{k_{\rm W}} = \Gamma(1 + \frac{1}{k_{\rm W}})$ with the Gamma function $\Gamma: (0, \infty) \mapsto \mathbb{R}_+$ given by $\Gamma(x) = \int_0^\infty t^{z-1} e^{-t} dt$. Thus, inserting Eq. (6) into Eq. (7), we get that

$$p \approx \frac{\alpha c_{\mathrm{P}} \nu_3 \left(\Xi_{\mathrm{solid}}^{(\mathrm{pr})}\right)^{c_{\mathrm{dim}}} c_{\mathrm{W}} \nu_3 \left(\Xi_{\mathrm{solid}}^{(\mathrm{pr})}\right)^{1-c_{\mathrm{dim}}} \gamma_{k_{\mathrm{W}}} \mathbb{E}\Delta}{\nu_3 \left(\Xi_{\mathrm{solid}}^{(\mathrm{pr})}\right)} = \nu_3 \left(\Xi_{\mathrm{solid}}^{(\mathrm{pr})}\right) \frac{\alpha c_{\mathrm{P}} c_{\mathrm{W}} \gamma_{k_{\mathrm{W}}} \mathbb{E}\Delta}{\nu_3 \left(\Xi_{\mathrm{solid}}^{(\mathrm{pr})}\right)} = \alpha c_{\mathrm{P}} c_{\mathrm{W}} \gamma_{k_{\mathrm{W}}} \mathbb{E}\Delta,$$

i.e., the porosity p of the crack network model P_{θ_2} does not (or only slightly) depend on the volume $\nu_3(\Xi_{\text{solid}}^{(\text{pr})})$ of the underlying pristine particle P_{pr} .

Finally, we remark that from now on, utilizing the representation of the scale parameters $\lambda_{\rm P}$ and $\lambda_{\rm W}$ introduced in Eq. (6), the following modified form of the parameter vector θ_2 of P_{θ_2} given in Eq. (5) will be used:

$$\theta_2 = (c_{\mathrm{W}}, k_{\mathrm{W}}, k_{\Gamma}, \theta_{\Gamma}, c_{\mathrm{P}}, c_{\mathrm{dim}}) \in \mathbb{R}^5_+ \times [0, 1].$$
(8)

352 3.5. Extended crack network model. Recall Section 2.3, where the set of experimentally 353 measured 2D SEM images \mathcal{G} was split into two classes, \mathcal{G}_{short} and \mathcal{G}_{long} , containing particle cross 354 sections showing either predominantly short or long cracks. Nevertheless, each crack network 355 exhibited on these cross sections, still consists of both, (relatively) short as well as (relatively) 356 long cracks, see Figure 2.

This is the reason why the crack network model that was introduced in Section 3.4 turns out to be insufficiently flexible. Therefore, we extend this model by realizing it twice on the same pristine particle $P_{\rm pr} = (\Xi_{\rm solid}^{\rm (pr)}, \emptyset)$, with two different parameter vectors

$$\theta_2^{(1)} = (c_{\rm W}^{(1)}, k_{\rm W}^{(1)}, k_{\Gamma}^{(1)}, \theta_{\Gamma}^{(1)}, c_{\rm P}^{(1)}, c_{\rm dim}^{(1)}) \qquad \text{and} \qquad \theta_2^{(2)} = (c_{\rm W}^{(2)}, k_{\rm W}^{(2)}, k_{\Gamma}^{(2)}, \theta_{\Gamma}^{(2)}, c_{\rm P}^{(2)}, c_{\rm dim}^{(2)}).$$

³Note that this approximation does not take the overlap of cracked facets into consideration.

360 In this way we obtain two independently cracked particles

$$P_{\theta_2^{(1)}} = (\Xi_{\text{solid}}^{(\theta_2^{(1)})}, \Xi_{\text{crack}}^{(\theta_2^{(1)})}) \qquad \text{and} \qquad P_{\theta_2^{(2)}} = (\Xi_{\text{solid}}^{(\theta_2^{(2)})}, \Xi_{\text{crack}}^{(\theta_2^{(2)})}),$$

which are used to get the extended crack network model $P_{\theta} = (\Xi_{\text{solid}}^{(\theta)}, \Xi_{\text{crack}}^{(\theta)})$ with $\theta = (\theta_2^{(1)}, \theta_2^{(2)})$, exhibiting a sufficiently large variety of short and long cracks, where

$$\Xi_{\text{crack}}^{(\theta)} = \Xi_{\text{crack}}^{(\theta_2^{(1)})} \cup \Xi_{\text{crack}}^{(\theta_2^{(2)})} \quad \text{and} \quad \Xi_{\text{solid}}^{(\theta)} = \Xi_{\text{solid}}^{(\text{pr})} \setminus \Xi_{\text{crack}}^{(\theta)}.$$
(9)

By visual inspection of the segmented SEM data, see Figure 2, it seems clear that short and long cracks exhibit similar thicknesses. This observation motivates a reduction of model parameters by setting $k_{\Gamma} = k_{\Gamma}^{(1)} = k_{\Gamma}^{(2)}$ and $\theta_{\Gamma} = \theta_{\Gamma}^{(1)} = \theta_{\Gamma}^{(2)}$. Furthermore, we assume that the influence of the volume $\nu_3(\Xi_{\text{solid}}^{(\text{pr})})$ of the underlying pristine particle P_{pr} on the distributions of the number and size of cracks is the same for short and long cracks, i.e., we assume that $c_{\text{dim}}^{(1)} = c_{\text{dim}}^{(2)} = c_{\text{dim}}$. Thus, the number of model parameters is reduced from 12 to 9, leading to the parameter vector

$$\theta = (c_{\mathrm{W}}^{(1)}, k_{\mathrm{W}}^{(1)}, c_{\mathrm{P}}^{(1)}, c_{\mathrm{W}}^{(2)}, k_{\mathrm{W}}^{(2)}, c_{\mathrm{P}}^{(2)}, k_{\Gamma}, \theta_{\Gamma}, c_{\mathrm{dim}}) \in \mathbb{R}^{8}_{+} \times [0, 1]$$
(10)

of the extended crack network model, where $c_{\rm W}^{(i)}, k_{\rm W}^{(i)}$ control the length, $c_{\rm P}^{(i)}$ the number and $k_{\Gamma}, \theta_{\Gamma}$ the thickness of cracks for $i \in \{1, 2\}$, whereas $c_{\rm dim}$ controls the influence of the volume $\nu_3(\Xi_{\rm solid}^{\rm (pr)})$ of $P_{\rm pr}$ on the distributions of the number and size of cracks.

It is important to note that the crack network model as well as the extended crack network model inherit isotropy from the single crack model.

4. Model calibration

The calibration of the extended crack network model proposed in Section 3.5 is organized as follows. First, in Section 4.1, we formulate a minimization problem to determine optimal values of the parameter vector θ given in Eq. (10). For this, in Section 4.2, three different geometric descriptors of image data are introduced. These geometric descriptors are used in Section 4.3 to define a loss function, which measures the discrepancy between experimentally imaged particle cross sections and those drawn from the crack network model. Finally, in Section 4.4, a numerical method is described for solving the minimization problem stated in Section 4.1.

4.1. Minimization problem. The extended crack network model parameters introduced in 383 Section 3.5 are separately fitted to both partitions, \mathcal{G}_{short} and \mathcal{G}_{long} , of the experimental data set 384 \mathcal{G} considered in Section 2.3. Thus, the optimization of the parameter vector θ given in Eq. (10) 385 is performed twice, for $\mathcal{G}_{\text{short}}$ and $\mathcal{G}_{\text{long}}$, where the discrepancy between geometric descriptors 386 of experimental image data and simulated image data drawn from the extended crack network 387 model is minimized. Figures 4 and 5 illustrate cross section realizations of virtual particles 388 drawn from the extended crack network model fitted to \mathcal{G}_{short} and \mathcal{G}_{long} , respectively, alongside 389 experimentally imaged cross sections. 390

Furthermore, it is important to note that the crack network morphology may significantly vary across different cross-section sizes, see Figure 1. To avoid systematic errors arising from comparing experimental and simulated cross sections of different sizes, we introduce several cross-section size classes. Thus, experimental and simulated cross-sections are only compared if they are approximately of the same size. More specifically, a simulated particle cross-section is compared to the average of all experimental cross-sections in the same size class.

12

375



FIGURE 4. Particle cross sections across various size classes, drawn from the extended crack network model calibrated to \mathcal{G}_{short} (top row) and corresponding representatives of \mathcal{G}_{short} (bottom row). The cross sections were scaled to the same size, while their actual sizes are indicated by their area-equivalent diameters.



FIGURE 5. Particle cross sections across various size classes, drawn from the extended crack network model calibrated to $\mathcal{G}_{\text{long}}$ (top row) and corresponding representatives of $\mathcal{G}_{\text{long}}$ (bottom row). The cross sections were scaled to the same size, while their actual sizes are indicated by their area-equivalent diameters.

For the sake of simplicity, we will use the following abbreviating notation, writing \mathcal{G} instead of 397 $\mathcal{G}_{\text{short}}$ and $\mathcal{G}_{\text{long}}$. Furthermore, for each d > 0, let \mathcal{G}_{d} be the restriction of \mathcal{G} to all particle cross 398 sections P_{ex} whose area-equivalent diameter $\operatorname{aed}(P_{\text{ex}})$ belongs to the interval $B_{\ell}(d) = [j\ell, (j+1)\ell)$ 399 with given length $\ell > 0$, where the integer $j \in \mathbb{N} \cup \{0\}$ is chosen such that $d \in [j\ell, (j+1)\ell)$. It 400 turned out that an interval length of $\ell \approx 1.29 \,\mu\text{m}$ balances a reasonable number of experimental 401 cross sections in each bin and, simultaneously, preserves a sufficiently fine subdivision of the 402 entire dataset \mathcal{G} , where this subdivision results into 11 size intervals $[0, \ell), \ldots, [10\ell, 11\ell)$, with 403 $11\ell \approx 14.1 \,\mu\text{m}^4$ However, since the stochastic 3D model for pristine NMC particles, described 404 in Section 3.1, has been calibrated to 3D nano-CT data [50], it happens that for some randomly 405 oriented planes $E \subset \mathbb{R}^2$, the cross sections $P_{\theta} \cap E$ of 3D particles drawn from the extended crack 406 network model P_{θ} are larger than the ones observed in the dataset \mathcal{G} , which were measured by 407 the 2D SEM technique. Thus, if the area-equivalent diameter of $P_{\theta} \cap E$ is larger than 11ℓ , which 408

⁴The interval length of $\ell \approx 1.29 \,\mu\text{m}$ corresponds to approximately 90 pixels of the experimental data.

is the upper bound of the largest size class $B_{\ell}(10)$ of the experimental data set \mathcal{G} (for both cases 410 $\mathcal{G} = \mathcal{G}_{\text{short}}$ and $\mathcal{G} = \mathcal{G}_{\text{long}}$), then $P_{\theta} \cap E$ is not considered in the minimization procedure.

411 This leads to the minimization problem

$$\widehat{\theta} = \underset{\theta \in \mathbb{R}^8_+ \times [0,1]}{\operatorname{argmin}} \quad \mathbb{E} L\Big(P_{\theta} \cap E, \mathcal{G}\big|_{\operatorname{aed}(P_{\theta} \cap E)}\Big), \tag{11}$$

where the expectation in Eq. (11) extends over cross sections $P_{\theta} \cap E$ such that $\operatorname{aed}(P_{\theta} \cap E) \leq 11\ell$, and $L(\cdot, \cdot)$ is some loss function, which measures the discrepancy between the cross section $P_{\theta} \cap E$ of the extended crack network model P_{θ} and particle cross sections belonging to the restriction $\mathcal{G}|_{\operatorname{aed}(P_{\theta} \cap E)}$ of \mathcal{G} .

416 4.2. Geometric descriptors of 2D image data. In this section, three different geometric 417 descriptors of 2D image data are considered: the two-point coverage probability function, the 418 crack-size distribution and the distance-to-background distribution. They will be determined 419 on (measured and simulated) particle cross sections, denoted by $P = (\Xi_{\text{solid}}, \Xi_{\text{crack}})$, where 420 $\Xi_{\text{solid}}, \Xi_{\text{crack}} \subset \mathbb{R}^2$. Furthermore, these descriptors will be employed in Section 4.3 to determine 421 the loss function considered in Eq. (11).

Since the extended crack model is isotropic, we did not consider structural descriptors of generated crack networks that could take directional dependencies into account.

Two-point coverage probability. For each $h \in [0, h_{\max}]$, where $h_{\max} > 0$ is some maximum distance, the so-called the two-point coverage probability, denoted by $\operatorname{prob}_{\Xi}(h)$, is the probability that two randomly chosen points $x_1, x_2 \in \Xi_{\operatorname{solid}} \cup \Xi_{\operatorname{crack}}$ of distance h belong to the particle phase $\Xi \in \{\Xi_{\operatorname{solid}}, \Xi_{\operatorname{crack}}\}$. This probability will be estimated by the number of pixel pairs $x_1, x_2 \in \Xi \cap \mathbb{Z}_{\rho}^2$ separated by distance h, divided by the total number of pixel pairs $x_1, x_2 \in (\Xi_{\operatorname{solid}} \cup \Xi_{\operatorname{crack}}) \cap \mathbb{Z}_{\rho}^2$ of distance h, i.e.,

$$\operatorname{prob}_{\Xi}(h) \approx \frac{\#\{x_1, x_2 \in \Xi \cap \mathbb{Z}_{\rho}^2 \colon |x_1 - x_2| = h\}}{\#\{x_1, x_2 \in (\Xi_{\operatorname{solid}} \cup \Xi_{\operatorname{crack}}) \cap \mathbb{Z}_{\rho}^2 \colon |x_1 - x_2| = h\}},$$

430 where $|\cdot|$ denotes the Euclidean norm in \mathbb{R}^2 , see e.g., [67] for further details.

For the data considered in the present paper, the two-point coverage probabilities $\operatorname{prob}_{\Xi_{\text{solid}}}(h)$ and $\operatorname{prob}_{\Xi_{\text{crack}}}(h)$ are estimated for all possible distances $h \in [0, h_{\max}]$ on the pixel grid, where $h_{\max} \approx 850 \text{ nm}$, because it turned out that the values obtained for $\operatorname{prob}_{\Xi_{\text{solid}}}(h)$ and $\operatorname{prob}_{\Xi_{\text{crack}}}(h)$ are typically constant for h > 850 nm. These probabilities are then interpolated utilizing cubic splines and evaluated for 30 equidistant values of h, corresponding to a step size of approximately 28 nm, which leads to the vectors of relative frequencies

$$\operatorname{prob}_{\operatorname{solid}}(P) = \left(\operatorname{prob}_{\Xi_{\operatorname{solid}}}(h_0), \operatorname{prob}_{\Xi_{\operatorname{solid}}}(h_1), \dots, \operatorname{prob}_{\Xi_{\operatorname{solid}}}(h_{29})\right) \in [0, 1]^{30}$$
(12)

437 and

$$\operatorname{prob}_{\operatorname{crack}}(P) = \left(\operatorname{prob}_{\Xi_{\operatorname{crack}}}(h_0), \operatorname{prob}_{\Xi_{\operatorname{crack}}}(h_1), \dots, \operatorname{prob}_{\Xi_{\operatorname{crack}}}(h_{29})\right) \in [0, 1]^{30},$$
(13)

438 where $h_i = i h_{\text{max}}/29$ for $i = 0, 1, \dots, 29$.

Crack-size distribution. The probability distribution of the size of a randomly chosen crack within a particle cross section $P = (\Xi_{\text{solid}}, \Xi_{\text{crack}})$ will also be incorporated into the loss function introduced in Eq. (11). Formally, a crack is considered to be a connected component of the crack phase Ξ_{crack} , where the crack size will be represented by the area-equivalent diameter of the crack.

14

Recall that $aed(\xi)$ denotes the area-equivalent diameter of a set $\xi \subset \mathbb{R}^2$. Furthermore, let 445 $\xi_1, \ldots, \xi_n \subset \Xi_{crack}$ denote the connected components of the crack phase Ξ_{crack} . The probability 446 density of the random crack size will then be estimated by a histogram with some bin width 447 w > 0, which is given by the relative frequencies

$$\text{prob}_{\text{size}}(k) = \frac{\#\{\xi \in \{\xi_1, \dots, \xi_n\}: \text{ aed}(\xi) \in [kw, (k+1)w)\}}{n}$$

for k = 0, 1, ..., 49, where we put w = 50 nm. Altogether, this leads to the vector of relative frequencies $\operatorname{prob}_{\operatorname{size}}(P) = (\operatorname{prob}_{\operatorname{size}}(0), \operatorname{prob}_{\operatorname{size}}(1), ..., \operatorname{prob}_{\operatorname{size}}(49)) \in [0, 1]^{50}$.

Distance-to-background distribution. Consider a randomly chosen point $X \in \Xi_{\text{crack}}$ within the crack phase Ξ_{crack} of a particle cross section $P = (\Xi_{\text{solid}}, \Xi_{\text{crack}})$, and the random (minimum) distance D from X to the background $\mathbb{R}^2 \setminus (\Xi_{\text{solid}} \cup \Xi_{\text{crack}})$ surrounding P, i.e.,

 $D = \min\{|X - y| : y \in \mathbb{R}^2 \setminus (\Xi_{\text{solid}} \cup \Xi_{\text{crack}})\}.$

The probability distribution of the random variable D will be taken into account as a third component in the loss function introduced in Eq. (11). Like for the crack sizes considered above, the probability density of D will be estimated by a histogram with some bin width w > 0, which is specified by the relative frequencies

$$\operatorname{prob}_{\operatorname{dist}}(k) = \frac{\#\{x \in \Xi_{\operatorname{crack}} \cap \mathbb{Z}_{\rho}^2 \colon \min\{|x-y| : y \in \mathbb{R}^2 \setminus (\Xi_{\operatorname{solid}} \cup \Xi_{\operatorname{crack}})\} \in [kw, (k+1)w)\}}{\#\Xi_{\operatorname{crack}} \cap \mathbb{Z}_{\rho}^2}$$

for k = 0, 1, ..., 119, where we put w = 50 nm. In summary, we obtain the vector of relative frequencies $\operatorname{prob}_{\operatorname{dist}}(P) = (\operatorname{prob}_{\operatorname{dist}}(0), \operatorname{prob}_{\operatorname{dist}}(1), ..., \operatorname{prob}_{\operatorname{dist}}(119)) \in [0, 1]^{120}$.

459 4.3. Loss function. We now specify the loss function $L(\cdot, \cdot)$ considered in Eq. (11), utilizing 460 the geometric particle descriptors stated in Section 4.2. Recall that the purpose of the loss 461 function is to measure the discrepancy between experimentally imaged particle cross sections 462 and those drawn from the extended crack network model stated in Section 3.5. In particular, 463 the loss function will be utilized in Section 4.4 to solve the minimization problem introduced in 464 Eq. (11).

Let \mathcal{G} denote some set of experimentally imaged particle cross sections, e.g. $\mathcal{G} = \mathcal{G}_{short}$. Furthermore, let

$$\overline{\text{prob}}_{\text{solid}}(\mathcal{G}) = \frac{1}{\#\mathcal{G}} \sum_{P = (\Xi_{\text{solid}}, \Xi_{\text{crack}}) \in \mathcal{G}} \text{prob}_{\text{solid}}(P).$$

be the componentwise average of the vector of relative frequencies given in Eq. (12). The averages $\overline{\text{prob}}_{\text{crack}}(\mathcal{G}), \overline{\text{prob}}_{\text{size}}(\mathcal{G})$ and $\overline{\text{prob}}_{\text{dist}}(\mathcal{G})$ for the two-point coverage probability of the crack phase, crack-size distribution and distance-to-background distribution are defined analogously. The loss function considered in Eq. (11) is then given by

$$L(P_{\theta} \cap E, \mathcal{G}|_{\operatorname{aed}(P_{\theta})}) = \operatorname{error}\left(\operatorname{prob}_{\operatorname{crack}}(P_{\theta} \cap E), \operatorname{prob}_{\operatorname{crack}}\left(\mathcal{G}|_{\operatorname{aed}(P_{\theta} \cap E)}\right)\right) \\ + \operatorname{error}\left(\operatorname{prob}_{\operatorname{solid}}(P_{\theta} \cap E), \operatorname{prob}_{\operatorname{solid}}\left(\mathcal{G}|_{\operatorname{aed}(P_{\theta} \cap E)}\right)\right) \\ + \operatorname{error}\left(\operatorname{prob}_{\operatorname{size}}(P_{\theta} \cap E), \operatorname{prob}_{\operatorname{size}}\left(\mathcal{G}|_{\operatorname{aed}(P_{\theta} \cap E)}\right)\right) \\ + \operatorname{error}\left(\operatorname{prob}_{\operatorname{dist}}(P_{\theta} \cap E), \operatorname{prob}_{\operatorname{dist}}\left(\mathcal{G}|_{\operatorname{aed}(P_{\theta} \cap E)}\right)\right),$$

where $\operatorname{error}(\cdot, \cdot)$ is an error function which quantifies the discrepancy between a random cross section $P_{\theta} \cap E$ of the extended crack network model P_{θ} , and the set $\mathcal{G}|_{\operatorname{aed}(P_{\theta} \cap E)}$ of experimentally imaged cross sections. More precisely, we consider the truncated mean absolute error

$$\operatorname{error}(x,y) = \frac{1}{n_{+}} \sum_{i=1}^{n_{+}} |x_{i} - y_{i}|$$
(14)

for $x = (x_1, \ldots, x_n), y = (y_1, \ldots, y_n) \in \mathbb{R}^n$, where $n_+ \leq n$ is the smallest integer $j \in \{1, \ldots, n\}$ such that $x_i = y_i = 0$ for all $i \in \{j + 1, \ldots, n\}$.

Note that truncating the sum in Eq. (14) at $n_{+} \leq n$ is motivated by the fact that the 476 components of the vectors of relative frequencies considered in Section 4.2 are equal to zero from 477 a certain index. For the two-point coverage probabilities $\operatorname{prob}_{\operatorname{solid}}(\cdot)$ and $\operatorname{prob}_{\operatorname{crack}}(\cdot)$ occurring 478 in Eqs. (12) and (13), respectively, this happens when the size of the particle cross section is 479 smaller than $h_{\rm max} \approx 850 \,\rm nm$. Furthermore, for $\rm prob_{size}(\cdot)$ and $\rm prob_{dist}(\cdot)$, some cross sections 480 may contain only features smaller than a certain threshold. Truncating the sum in Eq. (14) 481 ensures that the sum of absolute values of the right-hand side of Eq. (14) is normalized with the 482 actual number of non-zero components of both vectors $x, y \in \mathbb{R}^n$. Thus, this approach prevents 483 that the error considered in Eq. (14) is not appropriately weighted, which could occur if many 484 components of $x, y \in \mathbb{R}^n$ are equal to zero. 485

486 4.4. Numerical solution of the minimization problem. For solving the minimization 487 problem stated in Eq. (11), a Nelder-Mead approach [69] is utilized, where a Monte Carlo 488 simulation technique [70] is employed in each iteration step of the Nelder-Mead algorithm to 489 approximate the expected value of the loss $L(P_{\theta} \cap E, \mathcal{G}|_{aed(P_{\theta})})$.

This process involves averaging over numerous cross sections $P_{\theta}^{(i)} \cap E^{(i)}$, where $P_{\theta}^{(i)}$ is a 490 realization of the extended crack network model P_{θ} , and $E^{(i)}$ is a realization of the randomly 491 orientated plane $E \subset \mathbb{R}^3$ for each $i = 1, \ldots, n$ and some integer $n \in \mathbb{N}$. Recall that P_{θ} is 492 an isotropic model, i.e., the realizations of P_{θ} exhibit a statistically similar behavior in each 493 direction. Thus, it would be sufficient, to intersect each realization $P_{\theta}^{(i)}$ of P_{θ} with a single plane 494 $E_{x,v} \subset \mathbb{R}^3$, where $E_{x,v}$ denotes a plane that is orthogonal to the x-axis and has a certain distance 495 v > 0 from the origin $o \in \mathbb{R}^3$. However, to keep the computational effort low and, simultaneously, 496 increase the robustness of averaging, each realization $P_{\theta}^{(i)}$ is intersected at multiple distances 497 along the x-, y- and z- axis, respectively. Furthermore, to avoid interpolations of the pixelized 498 image data, cross sections are only taken at integer heights along the coordinate axes. 499

First, 100 pristine particles are drawn from the stochastic 3D model for polycrystalline NMC particles, which has been described in Section 3.1. Then, in each iteration step of the Nelder-Mead minimization algorithm, 32 out of these 100 particles, denoted by $P_{\rm pr}^{(i)} = (\Xi_{\rm solid}^{({\rm pr},i)}, \emptyset)$ for $i = 1, \ldots, 32$, are chosen with a probability proportional to their volume-equivalent diameter. Note that this selection method corresponds to the probability of intersecting a particle by a randomly chosen plane, as this is done in 2D SEM imaging [71].

Each pristine particle $P_{\text{pr}}^{(i)}$ serves as input for generating a realization of the extended crack network model P_{θ} , which results in 32 realizations of P_{θ} , denoted by $P_{\theta}^{(i)} = (\Xi_{\text{solid}}^{(\theta,i)}, \Xi_{\text{crack}}^{(\theta,i)})$ for $i = 1, \ldots, 32$. Additionally, for each realization $P_{\theta}^{(i)}$, multiple cross sections are generated by intersecting each simulated particle $P_{\theta}^{(i)}$ at 10%, 20%, ..., 90% of its size along the x-,y- and z-axis, respectively. This yields 32 realizations of P_{θ} , each sliced at 9 positions along 3 axes, which finally results into $32 \times 9 \times 3 = 864$ cross sections per iteration step. More formally, for each simulated particle $P_{\theta}^{(i)}$, we assume without loss of generality that it is located in the positive octant $\mathbb{R}^3_+ = [0, \infty)^3 \subset \mathbb{R}^3$ and touches the xy-plane, xz-plane and yz-plane. Furthermore, let $\operatorname{diam}_{\mathbf{x}}(P_{\theta}^{(i)})$ denote the Feret diameter of $P_{\theta}^{(i)}$ [72] along the x-axis, which is given by

$$\operatorname{diam}_{\mathbf{x}}(P_{\theta}^{(i)}) = \max\left\{v > 0 \colon \left(\Xi_{\operatorname{solid}}^{(\theta,i)} \cup \Xi_{\operatorname{crack}}^{(\theta,i)}\right) \cap E_{\mathbf{x},v} \neq \emptyset\right\},\tag{15}$$

i.e., $\operatorname{diam}_{\mathbf{x}}(P_{\theta}^{(i)})$ describes the size of $P_{\theta}^{(i)}$ in x-direction. Analogously, the Feret diameters of $P_{\theta}^{(i)}$ along the y- and z- axis will be denoted by $\operatorname{diam}_{\mathbf{y}}(P_{\theta}^{(i)})$ and $\operatorname{diam}_{\mathbf{z}}(P_{\theta}^{(i)})$, where the plane $E_{\mathbf{x},v}$ on the right-hand side of Eq. (15) is replaced by planes $E_{\mathbf{y},v}$ and $E_{\mathbf{z},v} \in \mathbb{R}^3$ that are orthogonal to the y- and z-axis, respectively, and have the distance v > 0 to the origin.

Then, the expected loss $\mathbb{E} L(P_{\theta} \cap E, \mathcal{G}|_{\operatorname{aed}(P_{\theta})})$, occurring in Eq. (11), is numerically approximated by

$$\mathbb{E}L\Big(P_{\theta}\cap E,\mathcal{G}\big|_{\operatorname{aed}(P_{\theta}\cap E)}\Big)\approx\frac{1}{864}\sum_{i=1}^{32}\sum_{\mathbf{a}\in\{\mathbf{x},\mathbf{y},\mathbf{z}\}}\sum_{j=1}^{9}L\Big(P_{\theta}^{(i)}\cap E(\mathbf{a},j,P_{\theta}^{(i)}),\mathcal{G}\big|_{\operatorname{aed}\left(P_{\theta}^{(i)}\cap E(\mathbf{a},j,P_{\theta}^{(i)}),\right)}\Big)$$

where $E(\mathbf{a}, j, P) = E_{\mathbf{a}, \text{round}(j/10 \cdot \text{diam}_{\mathbf{a}}(P))}$ and $\text{round}(\cdot)$ denotes rounding to the closest integer, as defined in Eq. (3).

Thus, in summary, to find the optimal parameter vector $\hat{\theta}$ which solves the minimization problem given in Eq. (11), in each iteration step of the Nelder-Mead algorithm we choose 32 pristine particles out of a pool of 100 realizations of the stochastic 3D model described in Section 3.1. These selected particles serve as input for the extended crack network model P_{θ} , where the expected loss is approximated by averaging over 864 cross sections.

Recall that the optimization procedure described above was separately applied to both data sets, \mathcal{G}_{short} and \mathcal{G}_{long} , resulting in two calibrated models which generate particles exhibiting predominately short or long cracks. In the following, we will refer to the extended crack network model calibrated to \mathcal{G}_{short} and \mathcal{G}_{long} as $P_{\hat{\theta}_{short}}$ and $P_{\hat{\theta}_{long}}$, where samples drawn from these two models are called short- and long-cracked particles, respectively.

534

5. Results and discussion

In this section we first show how the extended crack network model $P_{\hat{\theta}}$ can be validated, the 535 calibration of which to experimental data has been explained in Section 4. For this, further 536 geometric descriptors of 2D morphologies will be introduced in Section 5.1, which have not 537 been used for model calibration. Then, similarly to the model calibration approach considered 538 in Section 4, the distributions of these descriptors will be determined in Section 5.2 for simulated 539 2D cross sections, drawn from $P_{\hat{\theta}}$, and compared to those computed for experimental 2D SEM 540 data. Moreover, in Section 5.3, two transport-relevant particle descriptors are presented, which 541 influence the performance of Li-ion batteries, but can only be determined adequately if 3D data 542 is available. In Section 5.4, the distributions of these transport-relevant descriptors, namely the 543 relative shortest path length of Li transport in active material, as well as the relative specific 544 surface area of active material, are analyzed for simulated (pristine and cracked) 3D particles. 545

5.1. Additional geometric descriptors of 2D morphologies. For validating the goodness of model fit, six further descriptors of 2D morphologies are taken into account to compare planar cross-sections of the extended crack network model $P_{\hat{\theta}}$ to experimentally measured 2D SEM images described in Section 2. It is important to emphasize that the descriptors considered in the present section are not used during the calibration process explained in Section 4. Furthermore, note that these descriptors are defined for planar particle cross-sections $P = (\Xi_{\text{solid}}, \Xi_{\text{crack}})$, with $\Xi_{\text{solid}}, \Xi_{\text{crack}} \subset \mathbb{R}^2$, which are either the continuous representation of an experimentally measured particle cross-section, or derived by intersecting a simulated cracked 3D particle, drawn from $P_{\widehat{\theta}}$, with a randomly oriented plane $E \subset \mathbb{R}^3$.

Porosity. One of the most fundamental geometric descriptors of porous 2D morphologies is their porosity. In the case of a planar particle cross sections $P = (\Xi_{\text{solid}}, \Xi_{\text{crack}})$, the porosity $p \in [0, 1]$ can be given by

$$p = \frac{\nu_2(\Xi_{\text{crack}})}{\nu_2(\Xi_{\text{solid}} \cup \Xi_{\text{crack}})}$$

see also Eq.(7) in Section 3.4, where the porosity was assumed to be independent of the particle size. However, recall that the porosity was not used in Section 4 for calibrating the extended crack network model $P_{\hat{\theta}}$ to experimental data. In Section 5.2 we determine the (empirical) distribution of p for simulated 2D cross sections, drawn from $P_{\hat{\theta}}$, and compare it to that computed for experimental 2D SEM data.

Chord length. Let $v \in \{x \in \mathbb{R}^2 : |x| = 1\}$ be some predefined direction in \mathbb{R}^2 . Then, chords within the solid phase Ξ_{solid} can be obtained by intersecting Ξ_{solid} with (parallel) lines in direction v. In general, this intersection results in multiple line segments, which are referred to as chords, see Figure 6a for chords in y-direction, i.e., v = (0, 1). The probability distribution of the lengths of these line segments is called chord length distribution. Under the assumption of isotropy, the chord length distribution does not depend on the chosen direction v, see [67] for formal definitions.

For 2D SEM data the chord length distribution was estimated by considering chords in x- and y-direction. However, for simulated 3D particles, drawn from $P_{\hat{\theta}}$, chords along the z-direction were additionally taken into account, which increases robustness of the estimation. For the computation of chord lengths, the python package PoreSpy [73] was used.

Local entropy. The mean local entropy of a particle cross section $P = (\Xi_{\text{solid}}, \Xi_{\text{crack}})$ is a measure for the local heterogeneity of P. It can be defined in the by the following: First, assign each point $x = (x_1, x_2) \in \Xi_{\text{solid}} \cup \Xi_{\text{crack}} \subset \mathbb{R}^2$ its local entropy

$$E(x) = -\sum_{\Xi \in \{\Xi_{\text{solid}}, \Xi_{\text{crack}}\}} \varepsilon_{\Xi}(x) \log_2(\varepsilon_{\Xi}(x))$$

where $\varepsilon_{\Xi}(x) \in [0, 1]$ denotes the local volume fraction of phase $\Xi \in \{\Xi_{\text{solid}}, \Xi_{\text{crack}}\}$, Note that $\varepsilon_{\Xi}(x)$ is determined by means of the 15 × 15 neighborhood $K_{15}(x) \subset \mathbb{R}^2$ centered iat $x \in \Xi_{\text{solid}} \cup \Xi_{\text{crack}}$, and formally given by

$$\varepsilon_{\Xi}(x) = \frac{\nu_2(\Xi \cap K_{15}(x))}{\nu_2(\Xi_{\text{solid}} \cup \Xi_{\text{crack}} \cap K_{15}(x))},\tag{16}$$

where $K_{15}(x) = \{y = (y_1, y_2) \in \mathbb{R}^2 : |x - y| \le 15\}$ with $|x - y| = |x_1 - y_1| + |x_2 - y_2|$, being the so-called Manhattan metric. Then, the mean local entropy of the particle cross section $P = (\Xi_{\text{solid}}, \Xi_{\text{crack}})$ is given by

$$E(P) = \frac{1}{\nu_2(\Xi_{\text{solid}} \cup \Xi_{\text{crack}})} \int_{\Xi_{\text{solid}}, \Xi_{\text{crack}}} E(x) \, \mathrm{d}x \,, \tag{17}$$

i.e., by averaging the local entropy E(x) over all $x \in \Xi_{\text{solid}} \cup \Xi_{\text{crack}}$ belonging either to the crack or solid phase.



FIGURE 6. Geometric descriptors of 2D morphologies, including chord lengths (a) and local entropy (b) of an elongated particle, as well as the number of branching points within a magnified region (c) of a skeletonized crack network (d), along with the number and length of crack segments (e) in another, more spherical particle. Note that for illustrative purposes, the skeletons in (d) and (e) are dilated and the grain boundaries in (b), (d) and (e) are indicated.

In Section 5.2, the distribution of the mean local entropy E(P) given in Eq. (17) will be 585 estimated for 2D image data and, therefore, the local entropy $\varepsilon_{\Xi}(x)$ introduced in (16) will 586 be determined pixelwise. However, note that the latter quantity is highly sensitive to changes 587 of resolution, because a finer resolution corresponds to a kernel K_{15} containing more pixels to 588 cover a predefined area, potentially resulting in a higher local heterogeneity. Therefore, the 589 experimental 2D SEM data were downsampled to match the (coarser) resolution of the virtual 590 pristine particles drawn from the stochastic 3D model, as described in Section 3.1. Figure 6b 591 illustrates a visual impression of local entropy computed on pixelized image data. 592

Number of branching points. To investigate the branching behavior of the crack phase Ξ_{crack} of a particle cross section $P = (\Xi_{\text{solid}}, \Xi_{\text{crack}})$, we consider its skeleton, denoted by $\mathcal{S}(P)$, see also Section 2.3. Recall that in Section 2.3, each connected component of the crack phase has been represented by its center line, called skeleton segment and denoted by $S \in \mathcal{S}(P)$, where the family of all skeleton segments forms the skeleton. In the following, for each skeleton segment $S \in \mathcal{S}(P)$, we say that $x \in S$ is a branching point if there are at least three points $y_1, y_2, y_3 \in S$ such that $|x - y_i| = \varepsilon$, where the set $\varepsilon > 0$ is a sufficient small distance.

To estimate the distribution of the number of branching points from pixelized image data, for any $S \in \mathcal{S}(P)$ and $x \in S \cap \mathbb{Z}_{\rho}^2$, let $\dot{K}_3(x) = (K_3(x) \cap \mathbb{Z}_{\rho}^2) \setminus \{x\}$ denote the 3×3 neighborhood of x on the grid \mathbb{Z}_{ρ}^2 , excluding the point x itself. A point $x \in S \cap \mathbb{Z}_{\rho}^2$ is considered a branching point if $\#(S \cap \dot{K}_3(x)) \geq 3$, see Figure 6c, where $\dot{K}_3(x)$ is visualized in blue color.

The python package PlantCV has been used [74] to compute skeleton segments and branchingpoints.



FIGURE 7. Exemplary clipped 3D renderings of virtually generated cracked NMC particles, drawn from the extended crack network model. Cracks are indicated in red color, whereas individual grains are visualized in randomly chosen shades of blue. The top row, shows particles drawn from the extended crack model calibrated to $\mathcal{G}_{\text{short}}$, whereas the bottom row corresponds to $\mathcal{G}_{\text{long}}$. The left column features a particle with a volume-equivalent diameter of $\approx 4.6 \,\mu\text{m}$, while the right column shows one of $\approx 12.5 \,\mu\text{m}$.

Number and length of crack segments. By removing the branching points from a skeleton 606 segment $S \subset \mathcal{S}(P)$, we obtain various connected components of S which we refer to as crack 607 segments, see Figure 6e, where crack segments are indicated in different colors. Furthermore, 608 for validation of the fitted extended crack network model $P_{\hat{\theta}}$, we determine the distributions 609 of the number and length of crack segments for simulated 2D cross sections, drawn from $P_{\hat{a}}$, 610 and compare them to those computed for experimental 2D SEM data. Note that the notion of 611 crack segment length introduced in this section is different from that of crack size, which was 612 considered in Sections 4.2 to 4.4 for model fitting. 613

5.2. Model validation. To validate the extended crack network model, which has been cali-614 brated to experimental image data in Sections 4.2 to 4.4, the probability densities of the geo-615 metric descriptors stated in Section 5.1 are estimated using particle cross sections of 200 model 616 realizations drawn from each of the extended crack models $P_{\hat{\theta}_{\text{short}}}$ and $P_{\hat{\theta}_{\text{long}}}$. For a visual impression of realizations of the fitted model, we refer to Figure 7, which presents clipped 3D 617 618 renderings of virtually generated cracked NMC particles. To ensure comparability, only 2D cross 619 sections of the 3D realizations have been taken into account, which are extracted, similarly as 620 described in Section 4.4, at $10\%, 20\%, \ldots, 90\%$ of the particle size along x-,y- and z-direction, 621 resulting into $9 \cdot 3 \cdot 200 = 5400$ cross sections for both crack scenarios. For each of these cross 622 sections, thee porosity, mean local entropy, number of branching points, as well as the number 623 and length of crack segments are determined. Their probability densities, along with those 624 derived from experimental 2D SEM data, have been computed via kernel density estimation, 625 see Figure 8. 626



FIGURE 8. Probability densities of porosity, chord lengths, mean local entropy (top row), number of branching points, number and length of crack segments (bottom row). Blue areas indicate densities computed from SEM data, whereas orange areas correspond to densities for planar cross sections of 3D realizations of the extended crack network model. Within each subplot, the left column corresponds to the data set \mathcal{G}_{short} , and the right column to \mathcal{G}_{long} . The horizontal dashed lines indicate the mean values of the respective descriptors.

When comparing the probability densities shown in Figure 8, derived for each case from simu-627 lated and experimental data, respectively, it becomes clearly visible that these pairs of densities 628 exhibit similar shapes, indicating a suitable choice of model type and a quite good fit of model 629 parameters, for both data sets \mathcal{G}_{short} and \mathcal{G}_{long} . Even in cases where these pairs of probability 630 densities are slightly different from each other, like the densities of the porosity of short-cracked 631 particles (top row, left part, left pair of densities), their mean values, represented by horizontal 632 dashed lines, fit very well. On the other hand, for example, the porosity distribution of long-633 cracked particles (top row, left part, right pair of densities) exhibits a slightly larger deviation 634 of its mean value with respect to the corresponding mean value derived from simulated data. 635 Nevertheless, qualitatively, the overall shapes of the probability densities match quite well in 636 all cases. 637

In summary, the probability densities derived from simulated and experimentally measured image data show a high degree of agreement, indicating that the crack networks observed in 2D SEM data are accurately represented by the stochastic 3D model introduced in Section 3.

5.3. Transport-relevant particle descriptors in 3D. In this section, two geometric particle descriptors are considered, which influence the performance of Li-ion batteries, but can only be determined adequately if 3D image data is available. However, in general, the acquisition of 3D data by tomographic imaging is expensive in terms of time and costs. Therefore, in the present paper, these descriptors are estimated by means of a stochastic 3D model, i.e., from realizations of the extended crack network model P_{θ} , which has been introduced in Section 3 and calibrated by means of 2D image data in Section 4. Thus, in the following, we consider a cracked particle $P = (\Xi_{\text{solid}}, \Xi_{\text{crack}})$, where $\Xi_{\text{solid}}, \Xi_{\text{crack}} \subset \mathbb{R}^3$, drawn from the extended crack network model P_{θ} , and we consider its pristine counterpart $P_{\text{pr}} = (\Xi_{\text{solid}}^{(\text{pr})}, \emptyset)$ with $\Xi_{\text{solid}}^{(\text{pr})} = \Xi_{\text{solid}} \cup \Xi_{\text{crack}} \subset \mathbb{R}^3$, which serves as input for P_{θ} . Furthermore, by $\Xi_{\text{BG}} = \mathbb{R}^3 \setminus \Xi_{\text{solid}}^{(\text{pr})}$ we denote the background of both particles, P_{pr} and P.

In particular, relative shortest path lengths from active material of P to electrolyte (located in cracks and/or background) are considered. Note that this is an important particle descriptor, since during delithiation, lithium ions migrate from the active material to the surface of the particle, where deintercalation occurs. Moreover, we investigate the specific surface area of particles, showing how it is affected by cracking. Clearly, this is also a transport-relevant particle descriptor, because it characterizes the intercalating surface of a particle.

Relative shortest path lengths. The paths from randomly chosen locations within the active 658 material to electrolyte are analyzed to investigate the transport of Li during delithiation. First, 659 the case is considered that particles are embedded in liquid electrolyte, where open porosity 660 cracks are filled with electrolyte and transport path lengths may decrease. Furthermore, to 661 demonstrate that the extended crack network model P_{θ} introduced in Section 3 is not limited 662 to Li-ion batteries with liquid electrolyte, the case of solid electrolyte is considered to mimic 663 the behavior of all-solid-state batteries. Then, contrary to batteries with liquid electrolyte, 664 cracks caused by cycling are not penetrated with electrolyte. Thus, cracks can be considered as 665 obstacles to ion transport, which may increase transport path lengths. 666

A powerful tool to analyze transport paths within a given phase of a two-phase material is the 667 so-called geodesic tortuosity. It is a purely geometric descriptor, see e.g. [75], which is usually 668 estimated on image data by considering two parallel planes in \mathbb{R}^3 , the starting plane and the 669 target plane, denoted by $E_{\rm S}$ and $E_{\rm T}$ in the following. Then, for each $x \in E_{\rm S}$, the length of the 670 shortest path to the target plane $E_{\rm T}$ within the transport phase is determined and normalized 671 by the distance between the planes $E_{\rm S}$ and $E_{\rm T}$. For estimating the geodesic tortuosity in the 672 formal framework of random closed sets, we refer to [76]. In the present paper, the concept of 673 geodesic tortuosity is generalized by considering arbitrary starting and target sets $H_{\rm S}, H_{\rm T} \subset \mathbb{R}^3$ 674 such that $H_{\rm S} \cap H_{\rm T} = \emptyset$. 675

To investigate delithiation in the case of liquid electrolyte (LE), the shortest paths from 676 active material to electrolyte are determined by means of simulated 3D image data. For this, 677 the starting and target sets $H_{\rm S}, H_{\rm T}$ are discretized, where $H_{\rm S} = \Xi_{\rm solid}$ and $H_{\rm T} = \Xi_{\rm crack} \cup \Xi_{\rm BG}$. 678 Note that the union $\Xi_{crack} \cup \Xi_{BG}$ of cracks and background forms the continuous representation 679 of the target set, since cracks are filled with liquid electrolyte. On the other hand, to mimic 680 the behavior of so-called all-solid-state batteries with solid electrolyte (SE), where cracks serve 681 as obstacle, the starting and target sets are given by $H_{\rm S} = \Xi_{\rm solid}$ and $H_{\rm T} = \Xi_{\rm BG}$. In Figure 9, 682 examples of shortest paths are shown for the cases of liquid and solid electrolyte, alongside with 683 shortest paths in the corresponding pristine (i.e. non-cracked) particle. 684

For each $x \in H_{\rm S}$, the length of the shortest path within the active material from $x \in H_{\rm S}$ to the target set $H_{\rm T}$ is determined, where the transport phase is given by the set $\Xi = \Xi_{\rm solid}$ for a cracked particle, and by $\Xi = \Xi_{\rm solid}^{\rm (pr)} = \Xi_{\rm solid} \cup \Xi_{\rm crack}$ for the corresponding pristine particle. To compute these shortest path lengths, denoted by $\gamma_{\Xi}(x, H_{\rm T})$, Dijkstra's algorithm [77] was utilized, as implemented in the python package dijkstra3D.

Moreover, to investigate how cracking affects the shortest path lengths, we consider relative shortest path lengths, denoted by $\tau_{\text{LE}}(x, P)$ for liquid electrolyte and by $\tau_{\text{SE}}(x, P)$ for solid electrolyte. These quantities are determined by normalizing the shortest path length $\gamma_{\Xi}(x, H_{\text{T}})$, from $x \in H_{\text{S}}$ to the target set H_{T} within the transport phase $\Xi = \Xi_{\text{solid}}$ of a cracked particle, by

the length of the corresponding shortest path within the solid phase $\Xi_{\text{solid}}^{(\text{pr})}$ of the pristine particle 694 $P_{\rm pr}$. Note that the shortest path within the pristine particle represents the shortest path from 695 the $x \in H_S$ to the electrolyte before the particle is cracked. Thus, formally, the relative shortest 696 path lengths $\tau_{\rm LE}(x, P)$ and $\tau_{\rm SE}(x, P)$ for liquid and solid electrolyte, respectively, are as follows: 697

$$\tau_{\rm LE}(x,P) = \frac{\gamma_{\Xi_{\rm solid}}\left(x,\Xi_{\rm crack}\cup\Xi_{\rm BG}\right)}{\gamma_{\Xi_{\rm solid}^{\rm (pr)}}\left(x,\Xi_{\rm BG}\right)}, \qquad \tau_{\rm SE}(x,P) = \frac{\gamma_{\Xi_{\rm solid}}\left(x,\Xi_{\rm BG}\right)}{\gamma_{\Xi_{\rm solid}^{\rm (pr)}}\left(x,\Xi_{\rm BG}\right)} \tag{18}$$

698

for each $x \in H_{\rm S} = \Xi_{\rm solid}$, where $\Xi_{\rm solid}^{(\rm pr)} = \Xi_{\rm solid} \cup \Xi_{\rm crack}$. From Eq. (18) we get that $\tau_{\rm LE}(x, P) \leq 1$ and $\tau_{\rm SE}(x, P) \geq 1$ for each $x \in H_{\rm S} = \Xi_{\rm solid}$. This 699 indicates a decrease of shortest path lengths caused by cracking in the case of liquid electrolyte, 700 and an increase for solid electrolyte, as expected. 701



FIGURE 9. Shortest paths from active material (grey) to electrolyte, avoiding cracks (black); for a cracked particle embedded in liquid (purple) and solid (blue) electrolyte, respectively, and for the corresponding pristine particle (orange).

Finally, we consider the mean relative shortest path lengths $\tau_{\rm LE}(P)$ and $\tau_{\rm SE}(P)$, which are de-702 termined by averaging the relative shortest path lengths $\tau_{\rm LE}(x, P)$ and $\tau_{\rm SE}(P)$ given in Eq. (18) 703 over all $x \in \Xi_{\text{solid}}$. The concept of relative shortest path lengths is visualized in Figure 10 for 704 both kinds of (liquid and solid) electrolyte. 705

Relative specific surface area. Another descriptor related to effective properties of a particle 706 $P = (\Xi_{\text{solid}}, \Xi_{\text{crack}})$ is its specific surface area $\sigma(P)$. It indicates its surface area per unit volume 707 and is formally given by 708

$$\sigma(P) = \frac{\mathcal{H}_2(\partial \Xi_{\text{solid}})}{\nu_3(\Xi_{\text{solid}})},$$

where $\mathcal{H}_2(\cdot)$ denotes the 2-dimensional Hausdorff measure, $\nu_3(\cdot)$ the 3-dimensional Lebesgue 709 measure and $\partial \Xi$ the boundary of a set Ξ . Note that $\mathcal{H}_2(\cdot)$ measures the area of a 2-dimensional 710 manifold and $\nu_3(\cdot)$ the volume of a 3-dimensional set. Recall that in the present paper model 711 realizations are voxelized data. Therefore, the surface area of Ξ_{solid} is estimated using the 712 algorithm presented in [78] and the volume by counting voxels associated with Ξ_{solid} . 713

To investigate the change of the specific surface area caused by cracking, the relative specific 714 surface area, given by 715

$$\sigma_{\rm rel}(P) = \frac{\sigma(P)}{\sigma(P_{\rm pr})},$$

24

is considered, where $P_{\rm pr}$ denotes the underlying pristine particle corresponding to P. Note that 716 the relative specific surface area $\sigma_{\rm rel}(P)$ of P quantifies the increase of surface area per unit 717 volume due to cracking. In particular, $\sigma_{\rm rel}(P) = 1$ indicates no change, while larger values of 718 $\sigma_{\rm rel}(P)$ represent an increase in specific surface area caused by cracking. For example, $\sigma_{\rm rel}(P) =$ 719 2 indicates a doubling of the specific surface area. Notably, in a real Li-ion battery system, the 720 increase in specific surface area due to cracking is only beneficial for liquid electrolyte systems. 721 Additionally, the relative activity of newly exposed surfaces to electrochemical reactions will 722 depend on the availability of an electron at the surface between the electrolyte and active 723 material phase, which is not considered in the present work. 724



FIGURE 10. Relative shortest path lengths $\tau_{\text{LE}}(x, P)$ and $\tau_{\text{SE}}(x, P)$ for liquid (left) and solid electrolyte (right). Note that white indicates electrolyte, while bright yellow (right) indicate obstacles, formed by cracks. Additionally, gray within the particles corresponds to relative path lengths equal to one, indicating no change in the shortest path length due to cracking.

5.4. Structural analysis of simulated 3D particles. We now deploy the stochastic 3D model $P_{\hat{\theta}}$ of cracked particles that has been calibrated by means of 2D data to investigate the transport-relevant descriptors stated in Section 5.3 for simulated 3D particles drawn from $P_{\hat{\theta}}$. In particular, we investigate the probability distributions of the (relative) specific surface area and the mean relative shortest path length (for solid and liquid electrolyte) associated with the stochastic 3D model $P_{\hat{\theta}}$. More precisely, we will provide a detailed discussion of the corresponding probability densities of these descriptors, separately for the stochastic 3D model $P_{\hat{\theta}_{short}}$ calibrated to the data set \mathcal{G}_{short} , and for $P_{\hat{\theta}_{long}}$ calibrated to \mathcal{G}_{long} .

First, we draw 200 realizations from $P_{\hat{\theta}_{short}}$ which we denote by $P^{(i)}$ for i = 1, ..., 200. By computing the transport-relevant descriptors introduced in Section 5.3 for these realizations, we obtain four sample data sets, denoted by $\{\tau_{LE}(P^{(i)})\}_{i=1}^{200}, \{\tau_{SE}(P^{(i)})\}_{i=1}^{200}, \{\sigma(P^{(i)})\}_{i=1}^{200}$ and $\{\sigma_{rel}(P^{(i)})\}_{i=1}^{200}$. Then, by means of kernel density estimation on each of these four sets, we get probability densities of the corresponding transport-relevant particle descriptors, see the blue plots in Figures 11 and 12. Furthermore, the same procedure was applied to 200 realizations drawn from $P_{\hat{\theta}_{long}}$ to determine probability densities of the particle descriptors introduced in Section 5.3, see the green plots in Figures 11 and 12.



FIGURE 11. Probability densities of mean relative shortest path lengths $\tau_{\rm LE}(P)$ and $\tau_{\rm SE}(P)$ for liquid (left) and solid electrolyte (right). Each subfigure shows two probability densities, where the green (left) areas correspond to the probability densities computed from short-cracked particles and the blue (right) areas indicate the probability densities derived from long-cracked particles.

Note that the transport-relevant particle descriptors introduced in Section 5.3, with the exception of the specific surface area $\sigma(P)$, are computed by comparing descriptors of simulated cracked particles with those of the underlying pristine counterparts. Consequently, for pristine particles the mean relative shortest path length as well as the relative specific surface area are deterministic (i.e. non-random) quantities, being equal to 1. Therefore, when considering probability distributions of relative transport-relevant descriptors, only the specific surface area of pristine particles, see Figure 12 (left, purple), is of further interest.

The comparison of the probability densities shown in Figures 11 and 12 provides us with 748 quantitative insight into the transport behavior of cracked 3D particles, even though initially 749 only 2D data was available. For example, an intuitive result is that shortest path lengths 750 decrease after cracking for liquid electrolyte systems, i.e., the mean relative shortest path lengths 751 are typically smaller than 1, see Figure 11 (left). This is to be expected as cracks can be flooded 752 by the liquid electrolyte leading to shorter transport paths. On the other hand, shortest path 753 lengths increase for solid electrolyte, even though the relative increase is marginal, i.e., only 754 slightly above 1, see Figure 11 (right). 755

These general trends can be observed for both variants of the calibrated stochastic 3D model, $P_{\hat{\theta}_{\text{short}}}$ and $P_{\hat{\theta}_{\text{long}}}$. However, when comparing both models, we observe that—in the case of liquid relectrolyte—mean shortest path lengths seem to decrease more significantly for long-cracked particles rather than for short-cracked ones. For solid electrolyte systems, the difference in mean shortest path lengths between short- and long-cracked particles is much smaller, taking into account the finer length scale of the y-axis on the right-hand side of Figure 11.

In the case of liquid electrolyte, an explanation for the existence of shorter transport paths 762 is the fact that transport paths, which are originating in the active material phase, have the 763 option to end at the interface between active material and crack phases, instead of ending at 764 the background. In other words, caused by cracking, the set of possible endpoints of transport 765 paths originating in the active material becomes larger which possibly leads to a decrease of 766 shortest path lengths. On the other hand, in the case of solid electrolyte, only a small fraction 767 of shortest transport paths seems to be affected by cracking (which can cause obstacles to form). 768 Consequently, we observe mean relative shortest path lengths close to 1, see Figure 11 (right). 769 From the 2D illustrations of relative shortest path lengths in liquid and solid electrolyte, shown 770 in Figure 10, a visual impression of this effect can be obtained. 771

With respect to specific surface area, see Figure 12 (left), we observe that both scenarios (i.e., short- and long-cracked particles) lead to an increase of this geometric particle descriptor an effect that is more pronounced for long-cracked particles generated by $P_{\hat{\theta}_{\text{long}}}$. Moreover, the relative specific surface area quantifies this increase compared to the underlying pristine particle. Short-cracked particles exhibit an average increase in their specific surface area by a factor of 1.5 in comparison to their pristine counterparts, whereas this factor is equal to 2 for long-cracked particles, see Figure 12 (right).



FIGURE 12. Left: Probability densities of the specific surface area $\sigma(P)$ for pristine particles (purple) and for cracked particles drawn from the stochastic 3D models $P_{\hat{\theta}_{short}}$ (green) and $P_{\hat{\theta}_{long}}$ (blue). Right: Probability densities of the relative specific surface area $\sigma_{rel}(P)$ for cracked particles drawn from $P_{\hat{\theta}_{short}}$ (green) and $P_{\hat{\theta}_{long}}$ (blue), respectively.

In summary, it is important to note that the transport-relevant particle descriptors discussed 779 in this section, namely the mean relative shortest path length and the relative specific surface 780 area of cracked particles, are just examples of numerous further descriptors of 3D particles, which 781 cannot be adequately determined from 2D cross sections. Thus, the stereological approach to 782 stochastic 3D modeling of cracked particles proposed in the present paper can be used in future 783 research to provide geometry input for spatially resolved numerical modeling and simulation, 784 with the goal to derive quantitative structure-property relationships of cathode materials in 785 Li-ion batteries, e.g. with respect to mechanical and electrochemical properties. 786

787

6. CONCLUSION

This paper presents a novel approach for generating virtual 3D cathode particles with crack networks that are statistically equivalent to those observed in 2D cross-sections of experimentally manufactured particles, where a stochastic 3D model is developed which inserts cracks into virtually generated NMC particles, requiring solely 2D image data for model calibration.

An essential advantage of our model is that it enables the generation and analysis of a large number of virtual particle morphologies in 3D, whose planar 2D sections exhibit similar statistics as planar sections of experimentally manufactured particles. This computer-based procedure is cheaper, faster and more reliable than analyzing just a few experimentally manufactured particles. One reason for this is the circumstance that the acquisition of tomographic image data for a statistically representative number of particles can be expensive in both time and resources.

On the other hand, virtual particles generated by our stochastic 3D model allow for a more rigorous quantification of cracked NMC particles, i.e., by characterizing their 3D morphology

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and, subsequently, by conducting spatially resolved mechanical and electrochemical simulations
examining their structure-properties relationships. This supports the analysis and comparison
of different cycling conditions such as varying C-rate, operating temperature, or number of
cycles.

It is important to emphasize that the stochastic model presented in this paper for the 3D morphology of cracked NMC particles is characterized by a small number of (nine) interpretable parameters. In contrast to convolutional neural networks (CNNs), which have tens of thousands to several million trainable parameters, our stochastic 3D model has no "black-box" behavior and represents a low-parametric, transparent alternative to CNNs.

Moreover, our stochastic 3D model can be modified to involve further features that might in-810 fluence cracking, e.g., by generating cracks in dependence of the crystallographic orientation of 811 adjacent intraparticular grains. For example, this can be achieved by considering the misorien-812 tation between two neighboring grains, either replacing or supplementing the spatial alignment 813 of the joint grain boundary. To implement such a modified model, orientation data of NMC 814 particles is required, which could be derived, e.g., from EBSD measurements. Further, the 815 presented stochastic 3D crack model could be generalized by allowing for inhomogeneous and 816 anisotropic crack networks, e.g., by conditioning the cracking probabilities on radial distances 817 to the particle center or on the transport direction within the electrode. 818

Another advantage of our stereological modeling approach is the fact that it allows for the estimation of chemo-mechanical properties from 2D images. More precisely, since our model only requires 2D images to generate realistic 3D particle morphologies, it is possible to use these 3D morphologies as geometry input for spatially resolved simulations of effective particle properties, which would be otherwise impossible to get them on the basis of 2D image data.

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